

OUTLINE

Spectroscopy Group, Beamlines and Science Examples

- Spectroscopy group and measurements
- Beamline design and specifications
- Science examples from early experiments





SPECTROSCOPY GROUP

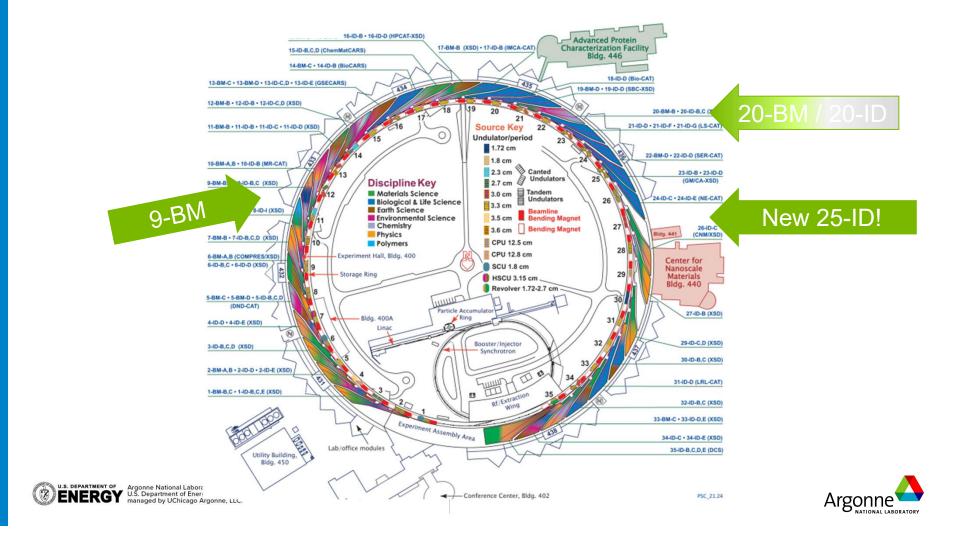


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SPC Group Beamlines: 20-BM, 9-BM, and 25-ID-C,D



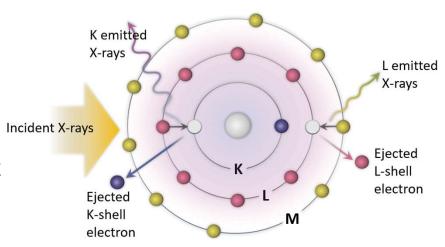




SPECTROSCOPY MEASUREMENTS

Probing electronic and atomic environment of atoms

- Scan x-ray energy through absorption edge recording absorption or fluorescence (XAS) or partial fluorescence (HERFD)
- Set the x-ray energy above the absorption edge recording fluorescent x-ray energy (XES)
- Scan x-ray energy far above absorption edge recording x-rays with energy loss from interaction with core electrons (XRS)



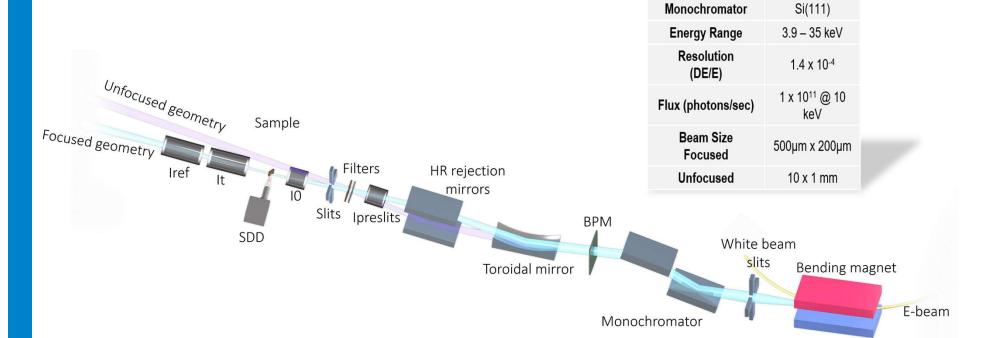
Combined with microprobe resolution and XRF mapping

The future will bring more image processing



20-BM X-RAY ABSORPTION SPECTROSCOPY

Highly productive XAS Beamline



Source

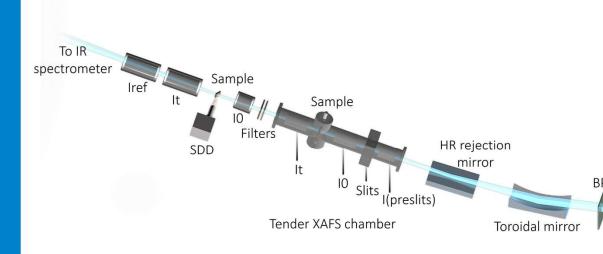
20-BM



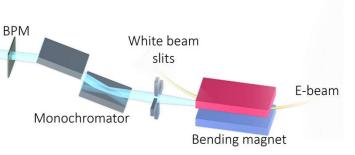


9-BM IN-SITU XAS BEAMLINE

Fast scanning, wide energy range, In-situ



Source	9-BM
Monochromator	Si(111), Si(220)
Energy Range	2.1 – 40 keV
Resolution (DE/E)	1 x 10 ⁻⁴
Flux (photons/sec)	1 x 10 ¹¹ @ 15 keV
Beam Size Focused	500 x 500 μm
Unfocused	3 x 1 mm







S-25 BASIC OPTICAL LAYOUT

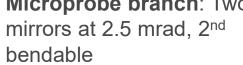
Horizontal deflecting mirrors to separate two beamlines

LERIX branch: bendable mirror at 2 mrad model mirrors 5-2

28-MM undulators

Microprobe branch: Two

Small offset doublecrystal/double-multilayer monochromators: 4-40 (32) keV with Si(111) 5-20 keV with multilayers



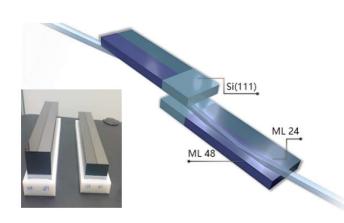




MONOCHROMATORS

Located in 25-ID-B

- Standard vertical deflection double crystal LN2 cooled
- Interferometers to monitor/correct crystal alignment
- Si(111) for entire energy range
- Small (10 mm) offset allows for multilayer
- Multilayers
 - 2 ML's (d=24 and 48 Å) to cover 5-21 keV
 - Accessed by small (~1 mm) vertical motion.
- Secondary mono Si (220 or 311) for higher energy resolution e.g. LERIX



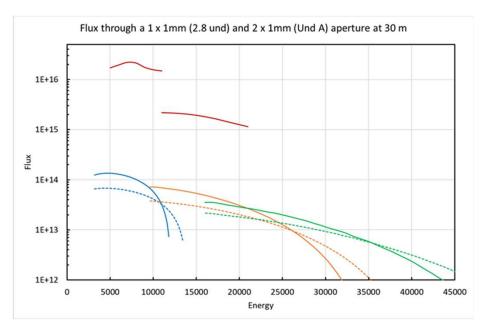
	Multilayers	Energy range	BW
ML 48 (d = 48 Å)	Mo (12 Å) + B ₄ C (36 Å)	4.9 – 10.7 keV	~ 3%
ML 24 (d = 24 Å)	Mo (10 Å) + B ₄ C (14 Å)	9.8 – 21.5 keV	~ 1%





MONOCHROMATORS

Located in 25-ID-B



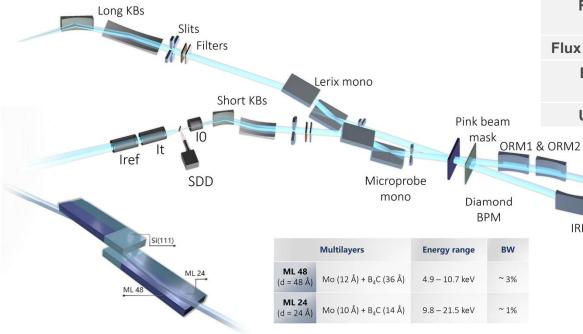
Multilayers enable non-resonant applications with much higher flux





SPECTROSCOPY GROUP

S-25 Advanced Spectroscopy



Source	25-ID-C/D	
Monochromator	Si(111), 2 nd Si(220)	Multilayer
Energy Range	4-40/32 keV	5-20 keV
Resolution (DE/E)	1.4 x 10 ⁻⁴	0.03
Flux (photons/sec)	1 x 10 ¹⁴	1x10 ¹⁵
Beam Size Focused	8 x 8 μm	
Unfocused	0.5 x 0.5 mm	

Microprobe

Slits

IRM





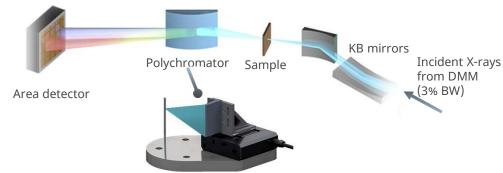
DISPERSIVE XAS DEMONSTRATION

Prototype success-fully commissioned

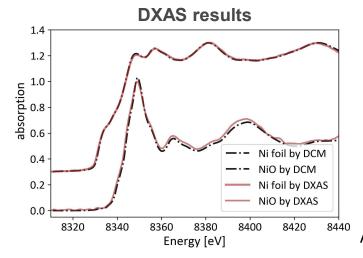
- DXAS, as a single-shot technique, offers significant advantages for XAS mapping and time-resolved measurements.
- Initial spectra measured on standard references samples replicate those from a DCM
- Combined with fly scanning of the sample stage to achieve rapid 2D XANES mapping capabilities, particularly for in situ and in operando measurements.

https://doi.org/10.1107/S1600577525004953.





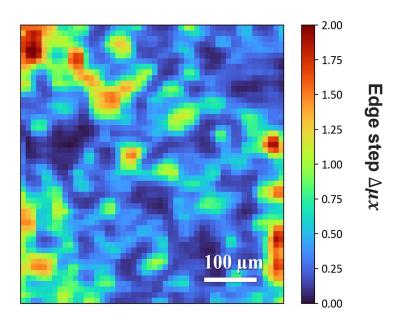
DXAS setup

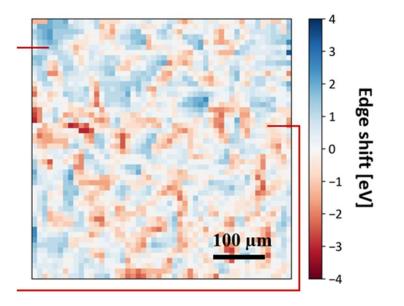




DISPERSIVE XANES MAPPING

Spatial maps of absorption and edge-shift derived from spatially resolved Dispersive XAS on a $Mn_xNi_yO_z$ laminate.



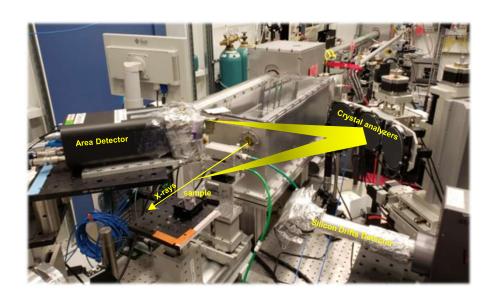


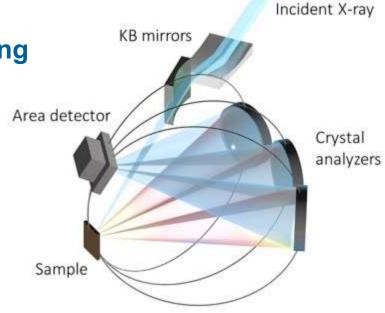




HERFD AT S-25

Three crystal spectrometer commissioning





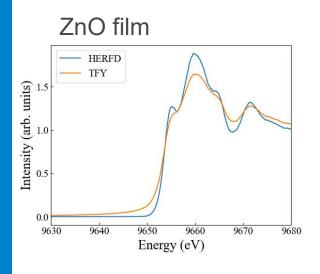
- Range of Si crystals available: Si(111), (100), (110), (211), (311), (773), (911)
- Common edges: Cr, Mn, Fe, Co, Ni, Cu, Zn, As, W, Au, Hg, Pb, U, Ce

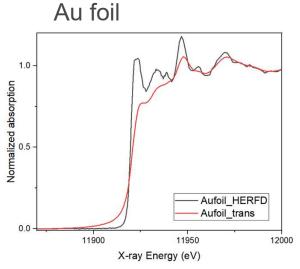


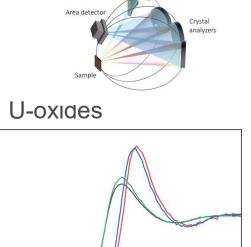


HERFD EXAMPLES AT S-25

From thin films, bulk foils to dilute U-oxides







Normalized absorption

17100

17125

17150

X-ray Energy (eV)

17175

KB mirrors

Incident X-ray

- Absorption edge features become more pronounced
- Sample differences are more apparent





800A_TFY 800A_PFY

800B PFY

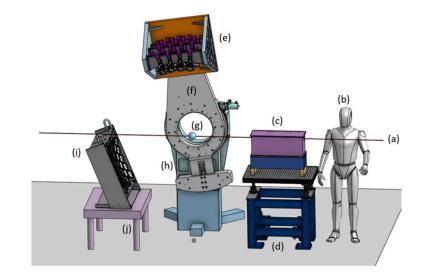
800B TFY

17200

X-RAY RAMAN SCATTERING (XRS)

Probing soft x-ray transitions with hard x-rays

- Low energy electron transitions with hard x-rays
 - Transitions from core shells of light elements
 - Transitions from higher shells of heavier elements
- Eliminates several complications of soft x-ray absorption
 - Hard x-rays are more easily combined with complex sample environments such as in-situ, in-operando, high pressure (diamond anvil), and liquid cells
 - Bulk sensitive (hard x-rays)
 - Free of self absorption (non-resonant)
- Sensitive to non-dipolar transitions
 - Momentum transfer dependent, can be minimized or enhanced
 - Access aspects of electronic structure unavailable in XAS

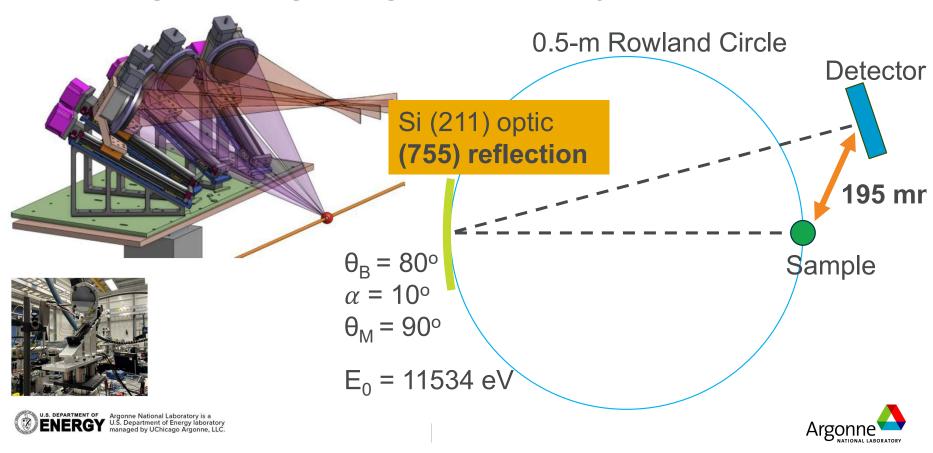






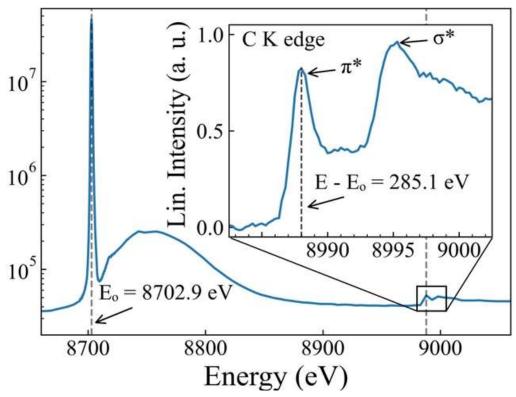
PROOF OF PRINCIPLE XRS DESIGN

S-25 testing XRS design using half-meter analyzers



PROOF OF PRINCIPLE XRS DESIGN

S-25 testing XRS design using half-meter analyzers

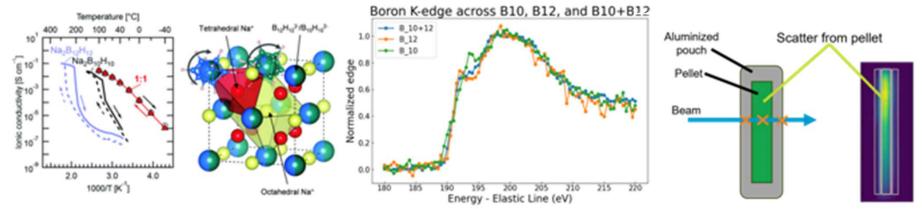






R&D ASYMMETRON FOR XRS AND HERFD

Single Optic used for 15 emission lines from 5 to 14 KeV



L. Duchêne et al. Chem. Commun., 53 (30), 4195-4198 (2017)

- Conductivity of Sodium Borates (B10 and B12) a promising class of solid-state electrolytes.
- X-ray Raman Scattering of Boron showing distinct chemical information for B10, B12 and mixture.
- Detector image of sample in pouch showing signal separation

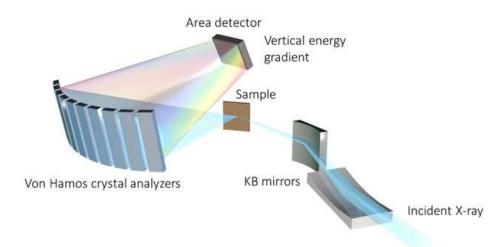




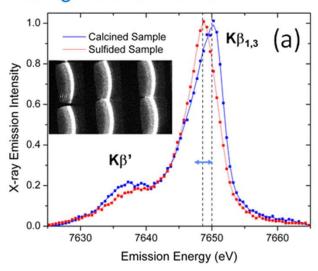
X-RAY EMISSION SPECTROSCOPY

Sensitive to spin state, valence, ligands

- Collection time from 30 sec to a few minutes
- Multilayer Monochromator after APS-U will allow sub-second integration time: mapping



Co emission from catalyst using miniXS – 30 sec



RESEARCH ARTICLE | FEBRUARY 08 2012

A plastic miniature x-ray emission spectrometer based on the cylindrical von Hamos geometry $\ensuremath{ \odot}$

B. A. Mattern; G. T. Seidler; M. Haave; J. I. Pacold; R. A. Gordon; J. Planillo; J. Quintana; B. Rusthoven





X-RAY EMISSION SPECTROSCOPY

Sensitive to spin state, valence, ligands

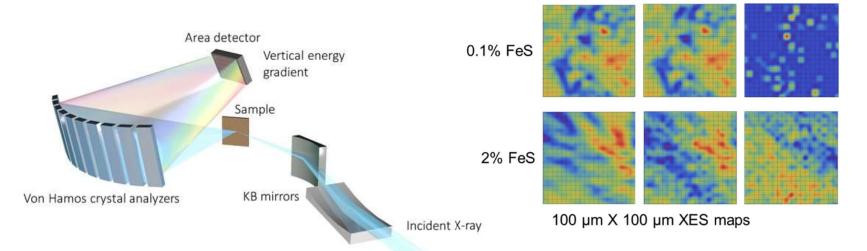
- Collection time from 30 sec to a few minutes
- Multilayer Monochromator after APS-U will allow sub-second integration time: mapping

Example: distinguishing Ni and NiCl₂ in a battery electrode

Bowden et al, J. Power Sources 247, 517-526 (2014)

Ni metal

NiCl₂



RESEARCH ARTICLE | FEBRUARY 08 2012

A plastic miniature x-ray emission spectrometer based on the cylindrical von Hamos geometry $\ensuremath{ \odot}$

Any Ni

B. A. Mattern; G. T. Seidler; M. Haave; J. I. Pacold; R. A. Gordon; J. Planillo; J. Quintana; B. Rusthoven

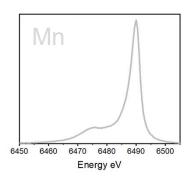


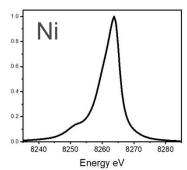


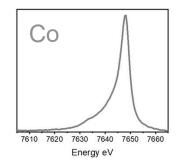
SPECTROMETER FOR MULTI-ELEMENT XES

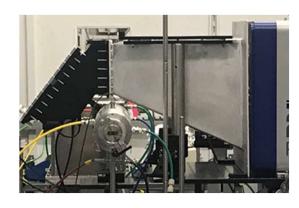
Large area detectors enable multiple element non-resonant XES

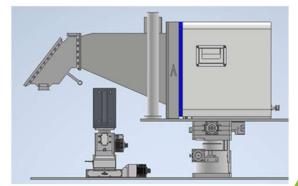
- Simultaneous XES spectra from nickel/manganese/cobalt on alumina cathode
- Simultaneous measurement
- Incident x-ray energy 8400 eV











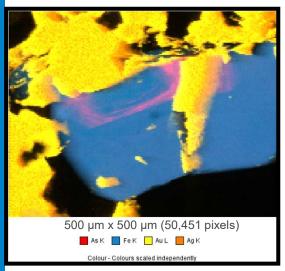




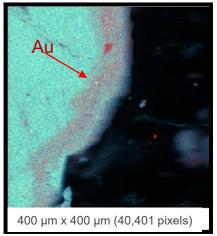
BONANZA GOLD MECHANISM

Microprobe XRF and Spectroscopy

Extremely high-resolution SR-µXRF mapping of arsenian pyrite reveals that bonanza-style gold mineralization was caused by gold flocculation from electron transfer near arsenic-rich bands.



The distribution of electrum (Au, ■ + Ag, ■) on the edges of corroded pyrite grains (Fe, ■) with As banding (As, ■) as fine as <2 µm (single pixel thickness!)

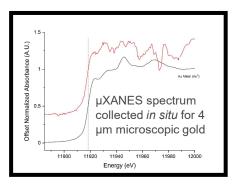


Microscopic metallic gold grain

(2 pixels wide, ■)

within the As band (As, ■)

on the edge of a pyrite grain (Fe, ■).



Microscopic gold within arsenian pyrite growth zone is metallic Au⁰ and not lattice bound Au⁺¹



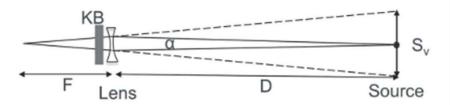
Dr. Neil R. Banerjee, P.Geo. Dr. Lisa L. Van Loon, C.Chem. XRF data analysis in Peakaboo (https://peakaboo.org)
Beam spot size: <2 μm x <2 μm
Energy: 26 keV

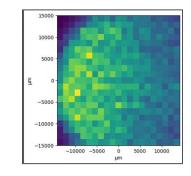
Argonne

DEVELOPMENTS TOWARD LARGE MAPPING

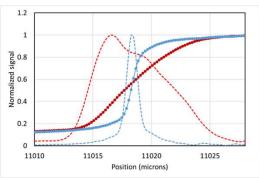
Fly scanning sample positioner and variable focus

- Fly scanning sample positioner
 - 4 hour measurement using weak Fe-57 source with 18 minutes (7.5%) overhead
- Easy/rapid and reliable beam size adjustment using Be lenses
 - Initial measurements made at 20-ID





30mm x 30mm 21x21 points 30sec/point





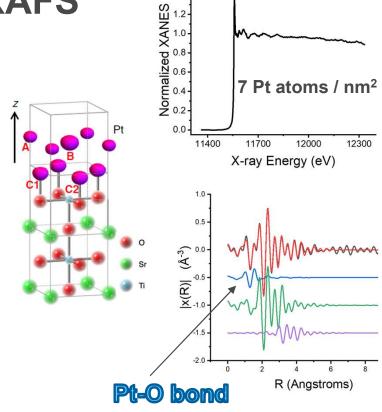




GRAZING INCIDENCE PT EXAFS

Pt monolayer on SrTiO₃ (001) substrate

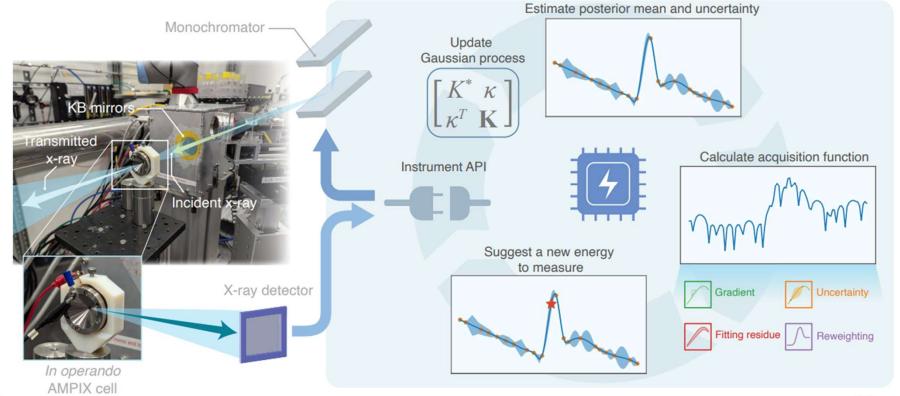
- Oxide supported noble metal nanoparticles are widely used as heterogeneous catalysts; playing an important role for the societal shift from a fossil-fuel to renewable energy sources.
- Studies of highly diluted monolayer and single atom catalyst are difficult, but necessary with catalyst development at the atomic-scale.
- Initial measurements show full EXAFS scans can be used to determine interfacial Pt-O bond







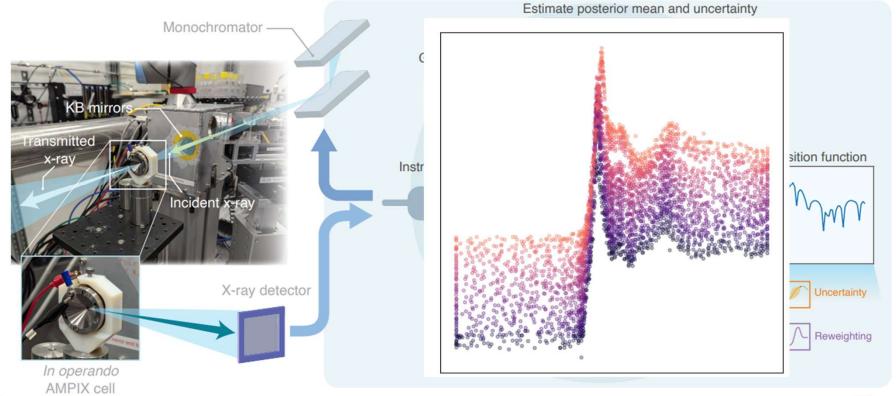
AI DRIVEN WORKFLOW FOR DYNAMIC SPECTROSCOPY





Argonne

AI DRIVEN WORKFLOW FOR DYNAMIC SPECTROSCOPY

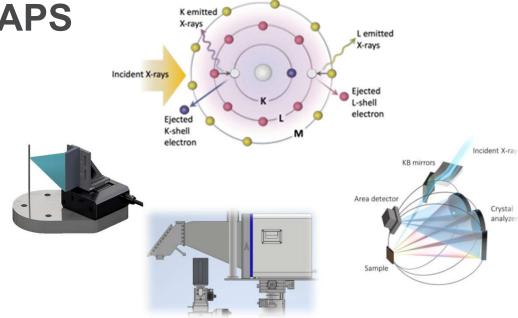




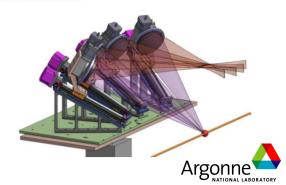


SPECTROSCOPY AT APS

- X-ray absorption spectroscopy
 - HERFD
 - Dispersive XANES
 - Grazing incidence
- X-ray emission spectroscopy
- X-ray Raman spectroscopy
- Micro spectroscopy, XRF+
 - confocal
- In-situ and Operando
 - Temperature
 - Pressure: DAC
 - Heterogeneous Catalysis
 - Energy Materials
 - IR









THANK-YOU FOR YOUR ATTENTION





